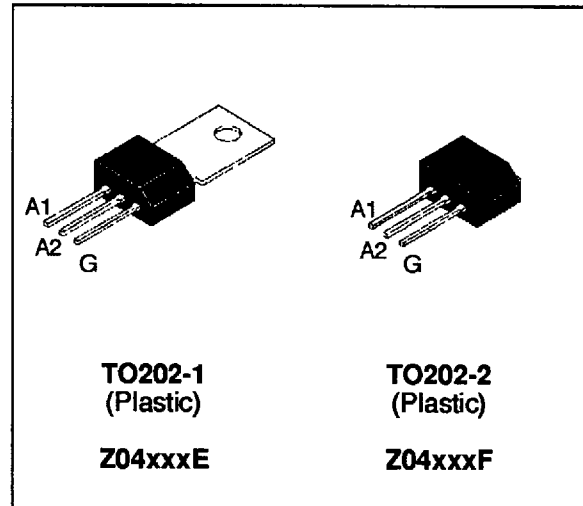


SENSITIVE GATE TRIACS
FEATURES

- $I_{T(RMS)} = 4A$
- $V_{DRM} = 400V$ to $800V$
- $I_{GT} \leq 3mA$ to $\leq 10mA$

DESCRIPTION

The Z04xxxE/F series of triacs uses a high performance TOP GLASS PNP technology. These parts are intended for general purpose applications where gate high sensitivity is required.


ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
$I_{T(RMS)}$	RMS on-state current (360° conduction angle)	Z04xxxE/F $T_c = 75^\circ C$	4	A
		Z04xxxF $T_a = 25^\circ C$	0.95	
I_{TSM}	Non repetitive surge peak on-state current (T_j initial = $25^\circ C$)	$t_p = 8.3$ ms	22	A
		$t_p = 10$ ms	20	
I^2t	I^2t Value for fusing	$t_p = 10$ ms	2	A^2s
di/dt	Critical rate of rise of on-state current $I_G = 50$ mA $di_G/dt = 0.1$ A/ μs .	Repetitive F = 50 Hz	10	A/ μs
		Non Repetitive	50	
T_{stg} T_j	Storage and operating junction temperature range		- 40, + 150 - 40, + 125	$^\circ C$
TI	Maximum lead temperature for soldering during 10s at 4.5mm from case		260	$^\circ C$

Symbol	Parameter	Voltage				Unit
		D	M	S	N	
V_{DRM} V_{RRM}	Repetitive peak off-state voltage $T_j = 125^\circ C$	400	600	700	800	V

Z04xxxE/F

THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
Rth(j-a)	Junction to ambient	Z04xxxE	80
		Z04xxxF	100
Rth(j-c)	Junction to case for D.C	10	°C/W
Rth(j-c)	Junction to case for A.C 360° conduction angle (F=50Hz)	7.5	°C/W

GATE CHARACTERISTICS (maximum values)

$P_G (AV) = 0.2 \text{ W}$ $P_{GM} = 3 \text{ W}$ ($t_p = 20 \mu\text{s}$) $I_{GM} = 1.2 \text{ A}$ ($t_p = 20 \mu\text{s}$)

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions	Quadrant		Sensitivity			Unit
				02	05	09	
I_{GT}	$V_D = 12\text{V (DC)}$ $R_L = 33\Omega$ $T_j = 25^\circ\text{C}$	I-II-III-IV	MAX	3	5	10	mA
V_{GT}	$V_D = 12\text{V (DC)}$ $R_L = 33\Omega$ $T_j = 25^\circ\text{C}$	I-II-III-IV	MAX	1.5			V
V_{GD}	$V_D = V_{DRM}$ $R_L = 3.3\text{k}\Omega$ $T_j = 125^\circ\text{C}$	I-II-III-IV	MIN	0.2			V
tgt	$V_D = V_{DRM}$ $I_G = 40\text{mA}$ $I_T = 5.5\text{A}$ $dI_G/dt = 0.5\text{A}/\mu\text{s}$ $T_j = 25^\circ\text{C}$	I-II-III-IV	TYP	2			μs
I_H^*	$I_T = 50\text{mA}$ Gate open $T_j = 25^\circ\text{C}$		MAX	3	5	10	mA
I_L	$I_G = 1.2 I_{GT}$ $T_j = 25^\circ\text{C}$	I-III-IV	TYP	3	5	10	mA
		II	TYP	6	10	20	
V_{TM}^*	$I_{TM} = 5.5\text{A}$ $t_p = 380\mu\text{s}$ $T_j = 25^\circ\text{C}$		MAX	2			V
I_{DRM} I_{RRM}	$V_D = V_{DRM}$ $V_R = V_{RRM}$ $T_j = 25^\circ\text{C}$		MAX	5			μA
			MAX	200			
dV/dt^*	$V_D = 67\%V_{DRM}$ Gate open $T_j = 110^\circ\text{C}$		MIN	10	20	100	V/ μs
			TYP	20	50	150	
$(dV/dt)_c^*$	$(dI/dt)_c = 0.55\text{A/ms}$ $T_j = 110^\circ\text{C}$		MIN	1	1	2	V/ μs
			TYP	1	1	2	

* For either polarity of electrode A_2 voltage with reference to electrode A_1

ORDERING INFORMATION

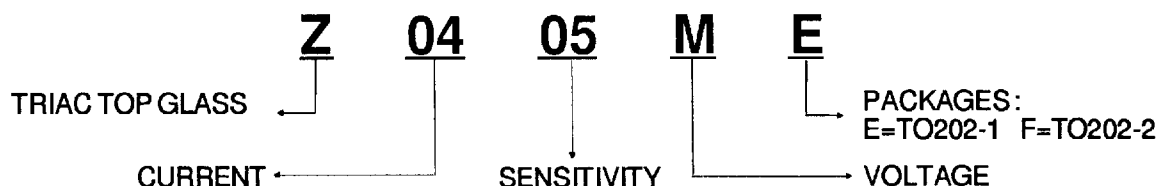


Fig.1 : Maximum RMS power dissipation versus RMS on-state current.

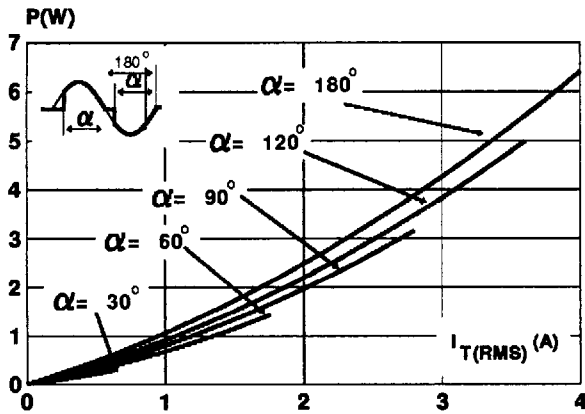


Fig.3 : Maximum RMS power dissipation versus RMS on-state current.

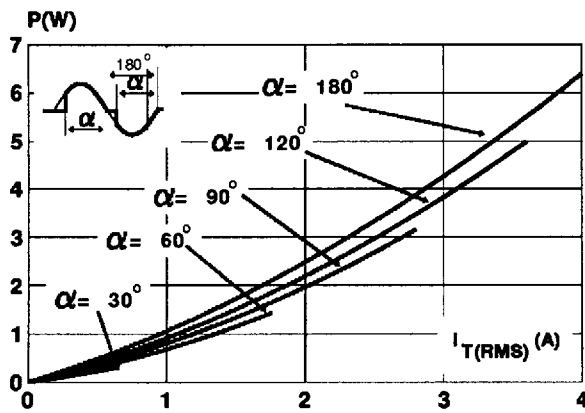


Fig.5 : RMS on-state current versus case temperature (TO202-1).

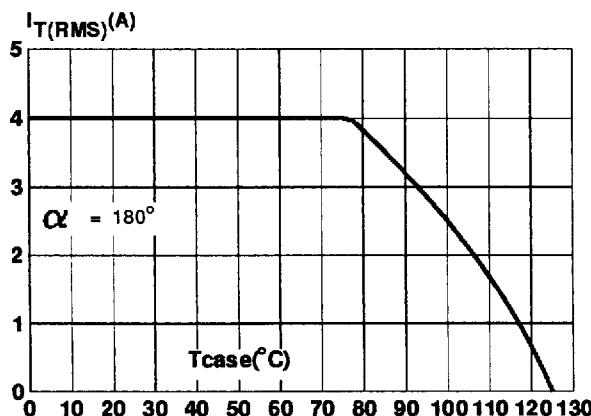


Fig.2 : Correlation between maximum RMS power dissipation and maximum allowable temperature (Tamb and Tcase) for different thermal resistances heatsink + contact (TO202-1).

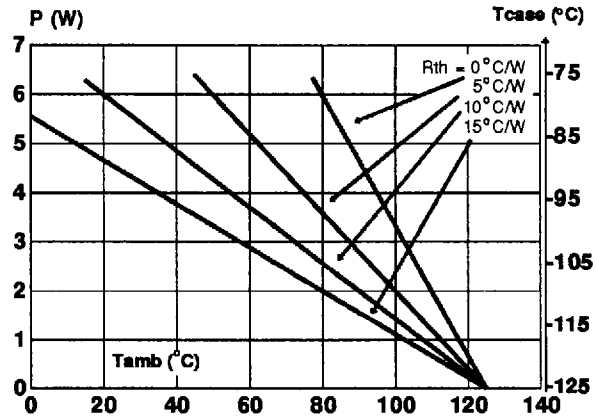


Fig.4 : Correlation between maximum RMS power dissipation and maximum allowable temperature (Tamb and Tcase) (TO202-2).

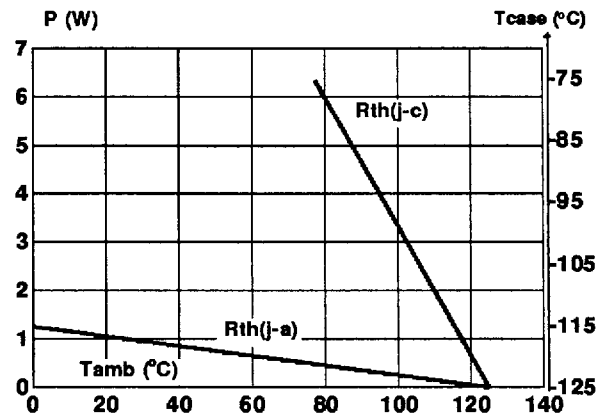


Fig.6 : RMS on-state current versus case temperature (TO202-2).

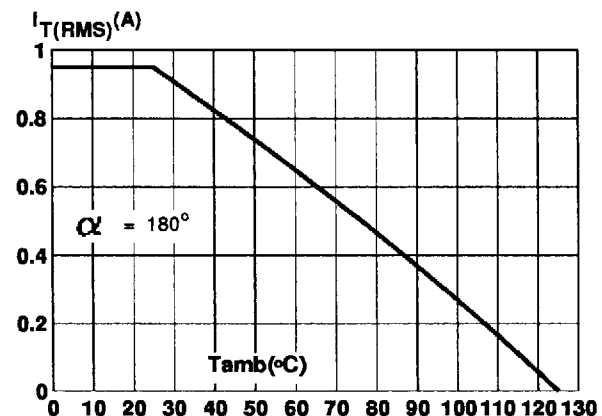


Fig.7 : Relative variation of thermal impedance versus pulse duration (TO202-1).

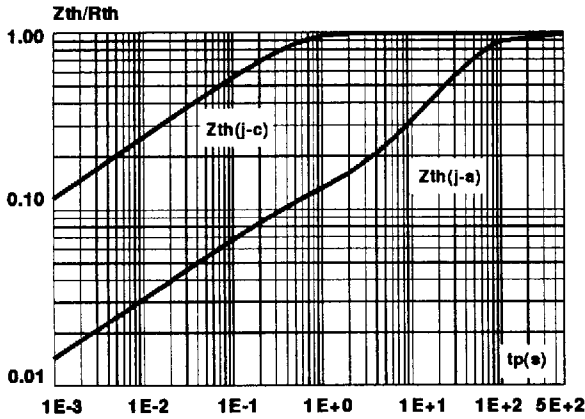


Fig.8 : Relative variation of thermal impedance junction to ambient versus pulse duration (TO202-2).

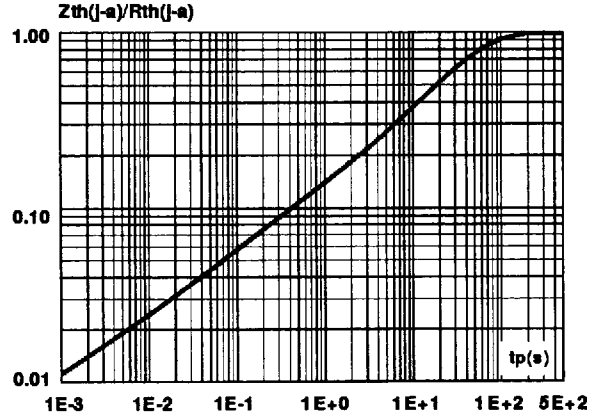


Fig.9 : Relative variation of gate trigger current and holding current versus junction temperature.

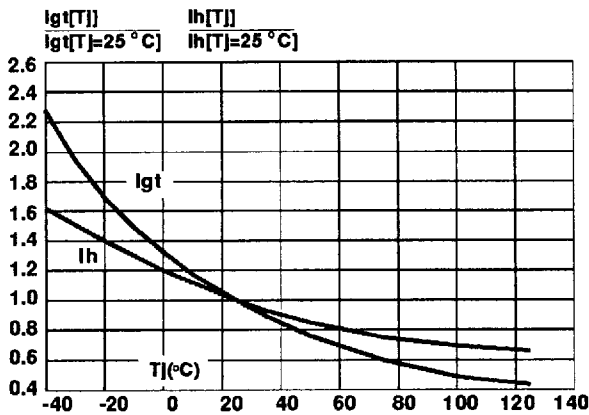


Fig.10 : Non repetitive surge peak on-state current versus number of cycles.

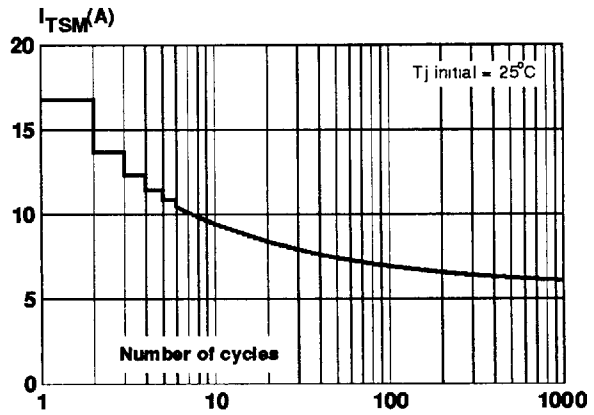


Fig.11 : Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t_p \leq 10\text{ms}$, and corresponding value of I^2t .

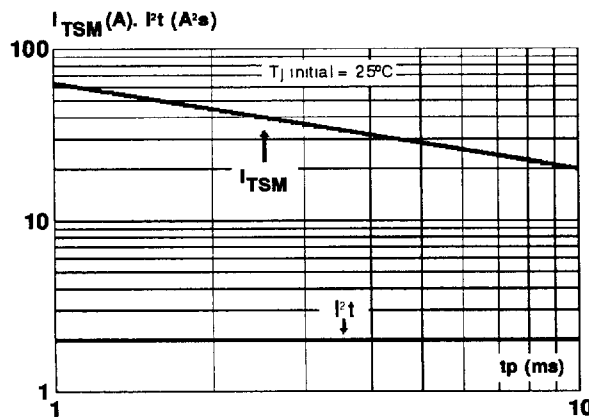
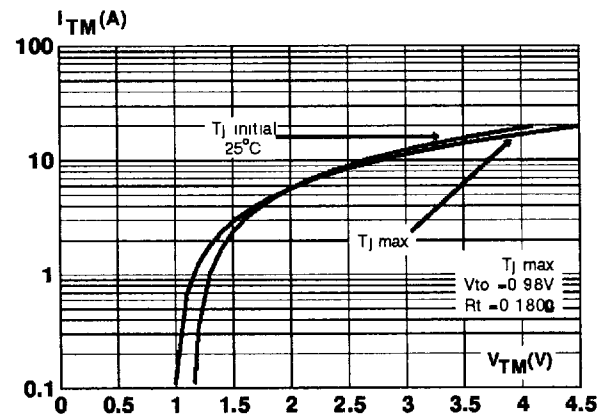
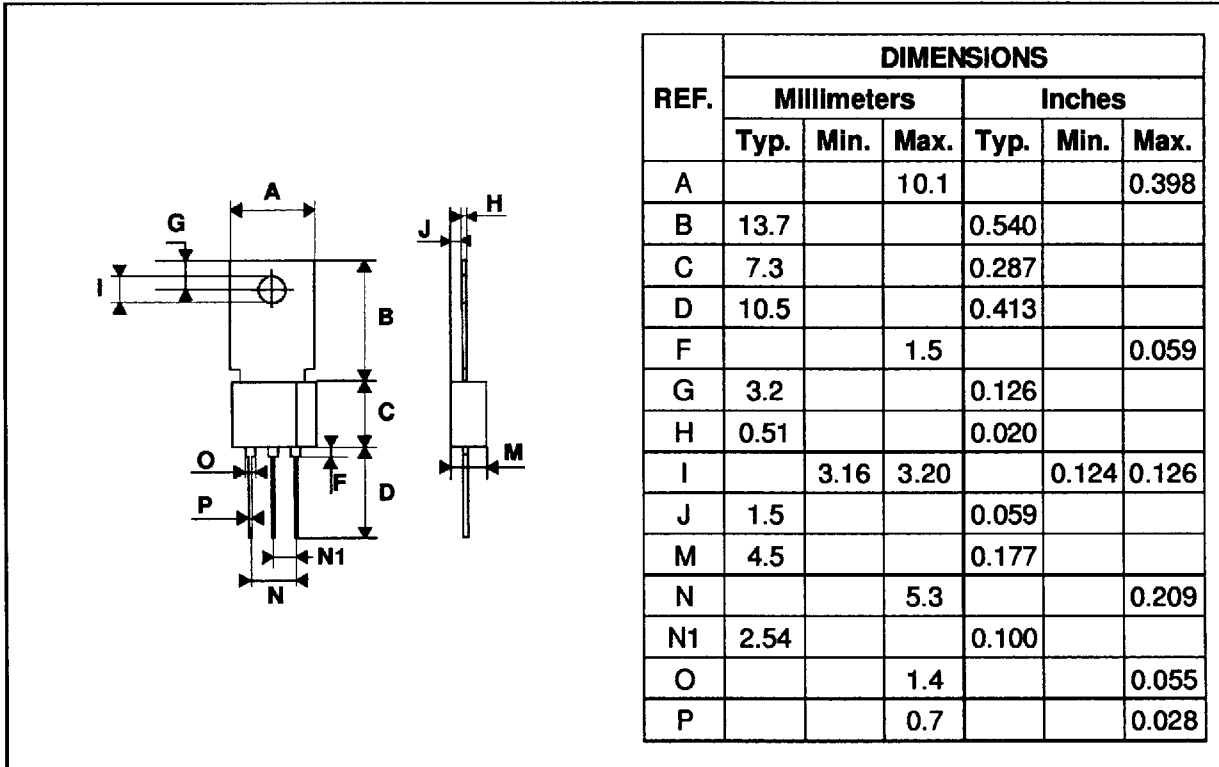


Fig.12 : On-state characteristics (maximum values).

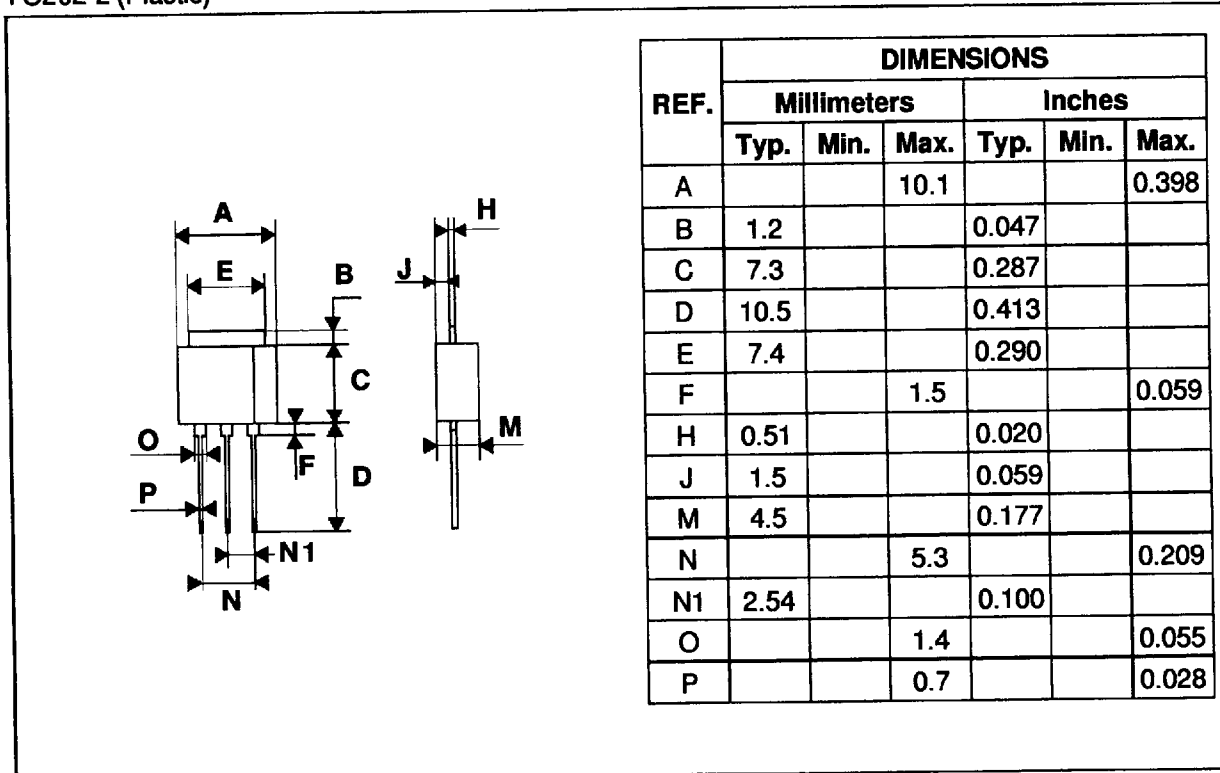


PACKAGE MECHANICAL DATA
TO202-1 (Plastic)



Marking : type number
Weight : 1.4 g

PACKAGE MECHANICAL DATA
TO202-2 (Plastic)



Marking : type number
Weight : 1.0 g

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